


<b>Search Notes</b>  	<b>Application/Control No.</b>  10600206	<b>Applicant(s)/Patent Under Reexamination</b>  SEGOTA ET AL.
	<b>Examiner</b>  Benjamin P Lee	<b>Art Unit</b>  3641

SEARCHED			
Class	Subclass	Date	Examiner
244	35R	11/2/2007	LEE
244	36	11/2/2007	LEE
244	200	11/2/2007	LEE
244	204	11/2/2007	LEE
244	211	11/2/2007	LEE
244	212	11/2/2007	LEE
244	213	11/2/2007	LEE
244	214	11/2/2007	LEE
244	215	11/2/2007	LEE
244	219	11/2/2007	LEE
244	226	1/2/2007	LEE

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	1/2/2007	LEE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner